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**Search Notes**

Application No.

09/407,136

Examiner

A. Dexter Tugbang

Applicant(s)

SHTEYNBERG ET AL.

Art Unit

3729

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	(above)	11/29/2004	ADT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

# SEARCHED

Class	Sub.	Date	Exmr.
29	605 602.1 604 596 732 735 33F	1/10/01	NOT
Updated (above)		6/10/01	NOT
Updated (above)		12/29/01	NOT
242	432 445 445.1 437.4		
310	254 259 194 269		
Updated (above)		4/19/02	NOT
Updated (above)		12/16/02	NOT
Updated (above)		6/30/03	NOT
Updated (above)		6/1/04	NOT

## INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	Date	Exmr.
Checked refs) Cited on U.S. Patent 6,163,952	6/16/01	NOT
Consulted L. Matecki, Primary Class 242	12/29/01	NOT
Consulted J. Wicks, Examiner Class 310		

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